


<b>Search Notes</b>  	<b>Application/Control No.</b>  10541763	<b>Applicant(s)/Patent Under Reexamination</b>  BICHOT ET AL.
	<b>Examiner</b>  WEI PO KAO	<b>Art Unit</b>  2464

SEARCHED			
Class	Subclass	Date	Examiner
370	310,328,329,338,431,445,447,351,389,390,461,462	1/17/08	MC
709	224,263,217,218,249	1/17/08	MC
same as above	same as above	1/21/09	MC
370	229 230 231 312 328 329 345 346 349 350 432 433 445 447 448 468 503 509 512	2/26/2009	wk
370	229 230 231 312 328 329 345 346 349 350 432 433 445 447 448 468 503 509 512	10/8/2009	wk
370	229 230 231 312 328 329 345 346 349 350 432 433 445 447 448 468 503 509 512	2/9/2010	wk
370	229 230 231 312 328 329 345 346 349 350 432 433 445 447 448 468 503 509 512	8/18/2010	wk

SEARCH NOTES		
Search Notes	Date	Examiner
East (All DBs) - See Attached	1/17/08	MC
same as above	1/21/09	MC
east search	2/26/2009	wk
plus search	2/26/2009	wk
class search	2/26/2009	wk
inventor name search	2/26/2009	wk
class search	10/8/2009	wk
east search	10/8/2009	wk
class search	2/9/2010	wk
east search	2/9/2010	wk
class search, east search	8/18/2010	wk

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/WEI-PO KAO/  
Examiner, Art Unit 2464